

FEATURES

- Double Side Cooling
- Fast Turn-on characteristics

APPLICATIONS

- Fast capacitor discharge
- Pulse power Applications
- Fast crowbar application

VOLTAGE RATINGS

| Part and Ordering Number | Repetitive Peak Off-state Voltage V_{DRM} V | Repetitive Peak Reverse Voltages V_{RRM} V |
|--------------------------|--|--|
| ACR300SG33 | 3300 $T_{vj} = -40^{\circ}\text{C to } 125^{\circ}\text{C}$, $I_{DRM} = 50\text{mA}$, $V_{DRM}, t_p = 10\text{ms}$, $V_{DSM} = V_{DRM} + 100\text{V}$ | 20 $T_{vj} = -40^{\circ}\text{C to } 125^{\circ}\text{C}$, $I_{RRM} = 50\text{mA}$, $V_{RRM}, t_p = 10\text{ms}$, $V_{RSM} = V_{RRM} + 100\text{V}$ |

Lower voltage grades available.

KEY PARAMETERS

| | |
|-------------|---------------------------------------|
| V_{DRM} | 3300V |
| $I_{T(AV)}$ | 493A |
| I_{TSM} | 6500A |
| dV/dt^* | 3000V/μs |
| dI/dt | 2000A/μs |
| t_{on} | 400ns |

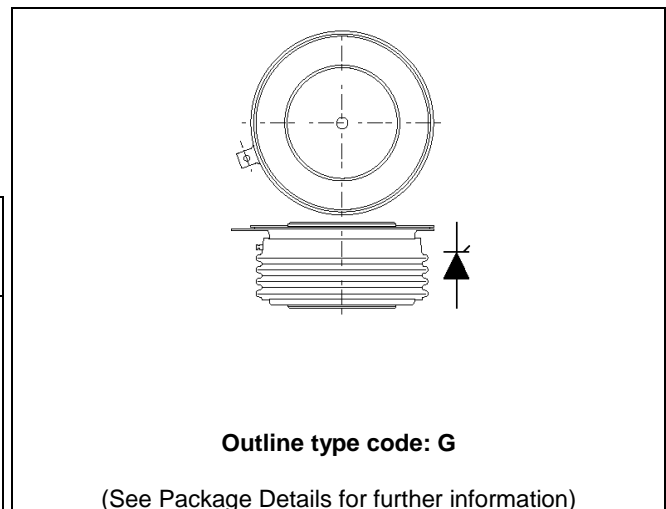


Fig. 1 Package outline

ORDERING INFORMATION

When ordering, select the required part number shown in the Voltage Ratings selection table.

For example:

ACR300SG33

Note: Please use the complete part number when ordering and quote this number in any future correspondence relating to your order.

CURRENT RATINGS

$T_{case} = 80^{\circ}\text{C}$ unless stated otherwise

| Symbol | Parameter | Test Conditions | Max. | Units |
|--|--------------------------------------|--------------------------|------|-------|
| Double Side Cooled | | | | |
| $I_{T(AV)}$ | Mean on-state current | Half wave resistive load | 493 | A |
| $I_{T(RMS)}$ | RMS value | - | 774 | A |
| I_T | Continuous (direct) on-state current | - | 630 | A |
| Single Side Cooled (Anode side) | | | | |
| $I_{T(AV)}$ | Mean on-state current | Half wave resistive load | 343 | A |
| $I_{T(RMS)}$ | RMS value | - | 539 | A |
| I_T | Continuous (direct) on-state current | - | 420 | A |

SURGE RATINGS

| Symbol | Parameter | Test Conditions | Max. | Units |
|-----------|---|--|------|-----------------------|
| I_{TSM} | Surge (non-repetitive) on-state current | 10ms half sine, $T_{case} = 125^{\circ}\text{C}$ | 6.5 | kA |
| I^2t | I^2t for fusing | $V_R = 0$ | 211 | kA^2s |

THERMAL AND MECHANICAL RATINGS

| Symbol | Parameter | Test Conditions | Min. | Max. | Units | |
|---------------|---------------------------------------|---|-------------|------|--------------------|----------------------|
| $R_{th(j-c)}$ | Thermal resistance – junction to case | Double side cooled | DC | - | 0.042 | $^{\circ}\text{C/W}$ |
| | | Single side cooled | Anode DC | - | 0.070 | $^{\circ}\text{C/W}$ |
| | | | Cathode DC | - | 0.092 | $^{\circ}\text{C/W}$ |
| $R_{th(c-h)}$ | Thermal resistance – case to heatsink | Clamping force $7.0 \pm 1\text{kN}$ (with mounting compound) | Double side | - | 0.018 | $^{\circ}\text{C/W}$ |
| | | | Single side | - | .036 | $^{\circ}\text{C/W}$ |
| T_{vj} | Virtual junction temperature | On-state (conducting) | - | 135 | $^{\circ}\text{C}$ | |
| | | Reverse (blocking) | - | 125 | $^{\circ}\text{C}$ | |
| T_{stg} | Storage temperature range | | -55 | 125 | $^{\circ}\text{C}$ | |
| F_m | Clamping force | | 6 | 8 | kN | |

DYNAMIC CHARACTERISTICS

| Symbol | Parameter | Test Conditions | Min. | Max. | Units |
|-------------------|---|--|------|------|------------|
| V_{TM} | Maximum on-state voltage | At 1000A peak, $T_{case} = 25^{\circ}C$ | - | 2.0 | V |
| I_{RRM}/I_{DRM} | Peak reverse and off-state current | At V_{RRM}/V_{DRM} , $T_{case} = 125^{\circ}C$ | - | 60 | mA |
| dV/dt | Max. linear rate of rise of off-state voltage | To $V_D = 2000V$, $T_j = 125^{\circ}C$, gate open | 3000 | | V/ μs |
| di/dt | Rate of rise of on-state current | From V_{DRM} to 125A Gate source 30V, 10 Ω , Gate rise time $t_r \leq 100ns$, $T_j = 125^{\circ}C$ | | 2000 | A/ μs |
| $V_{T(TO)}$ | Threshold voltage | $T_{vj} = 125^{\circ}C$ | - | 1.19 | V |
| r_T | On-state slope resistance | $T_{vj} = 125^{\circ}C$ | - | 0.81 | m Ω |
| t_{gd} | Delay time | $V_D = 3000V$, gate source 30V, 10 Ω Gate rise time $t_r = 100ns$, $T_j = 25^{\circ}C$ | - | 350 | ns |
| t_r | Rise time | As defined in Figure 2 $T_j = 25^{\circ}C$ | | 50 | ns |
| I_L | Latching current | $T_j = 25^{\circ}C$, $V_D = 5V$ | - | 600 | mA |
| I_H | Holding current | $T_j = 25^{\circ}C$, $R_{G-K} = \infty$, $I_{TM} = 500A$, $I_T = 5A$ | - | 300 | mA |

GATE TRIGGER CHARACTERISTICS AND RATINGS

| Symbol | Parameter | Test Conditions | Max. | Units |
|-------------|---------------------------|---|------|-------|
| V_{GT} | Gate trigger voltage | $V_{DWM} = 12V$, $R_L = 6\Omega$ $T_{case} = 25^{\circ}C$ | 5 | V |
| I_{GT} | Gate trigger current | $V_{DWM} = 12V$, $R_L = 6\Omega$ $T_{case} = 125^{\circ}C$ | 500 | mA |
| V_{FGM} | Peak forward gate voltage | | 40 | V |
| V_{RGM} | Peak reverse gate voltage | | 10 | V |
| I_{FGM} | Peak forward gate current | | 20 | A |
| P_{GM} | Peak gate power | | 40 | W |
| $P_{G(AV)}$ | Average gate power | Average time 10ms max | 10 | W |

CURRENT CARRYING CAPABILITY AFTER DEVICE SHORT CIRCUIT

In the event of a chip short-circuit due to excess anode-cathode voltage, the device will handle a high continuous RMS fault current without significant damage. Rating details are as follows:

Continuous current capability: 300A RMS, ac or dc in either direction.

Conditions:

1. Device single or double side cooled.
2. Case temperature to be held at 200°C or less.
3. A suitable high temperature clamp to be used.
4. Chip fault site resistance assumed to be $3m\Omega \pm 10\%$.

CURVES

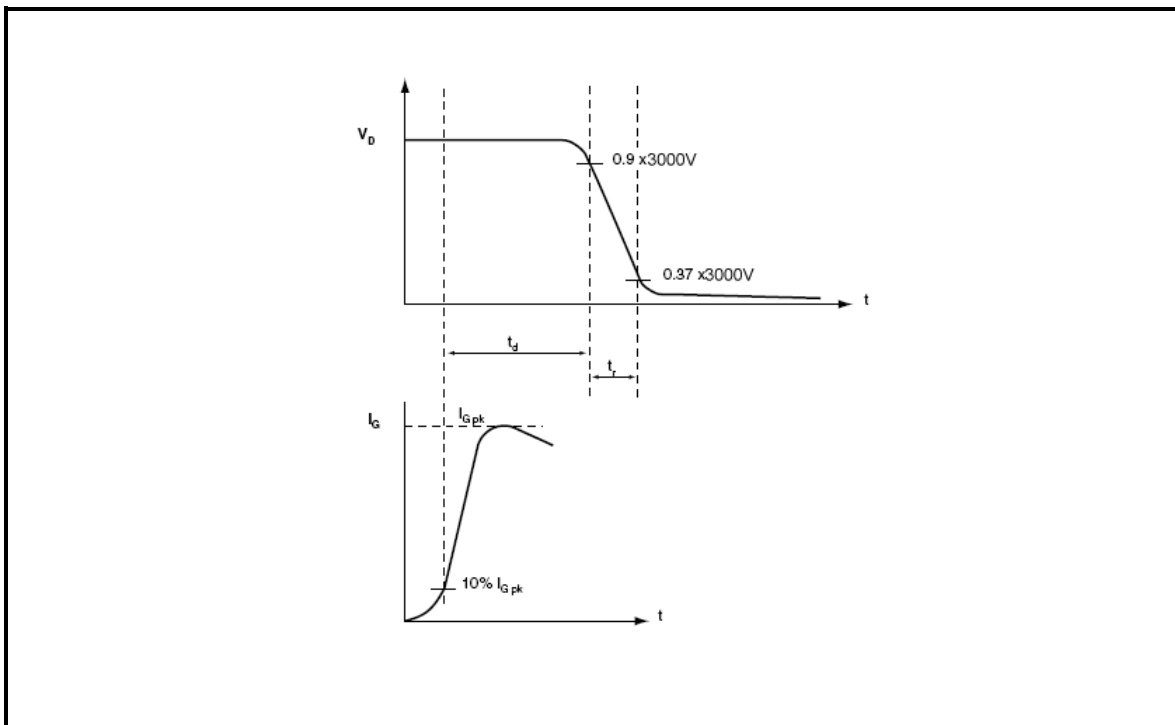


Fig.2 Turn-on time measurement

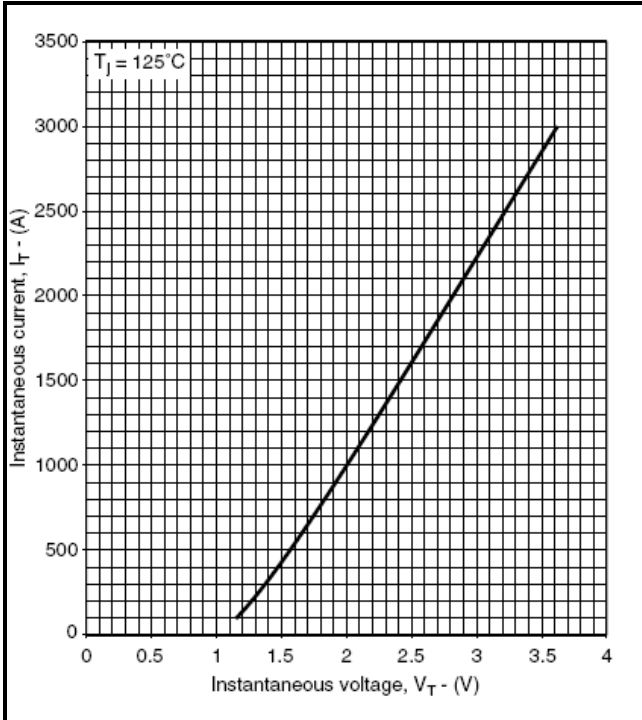


Fig.3 On-state Characteristics

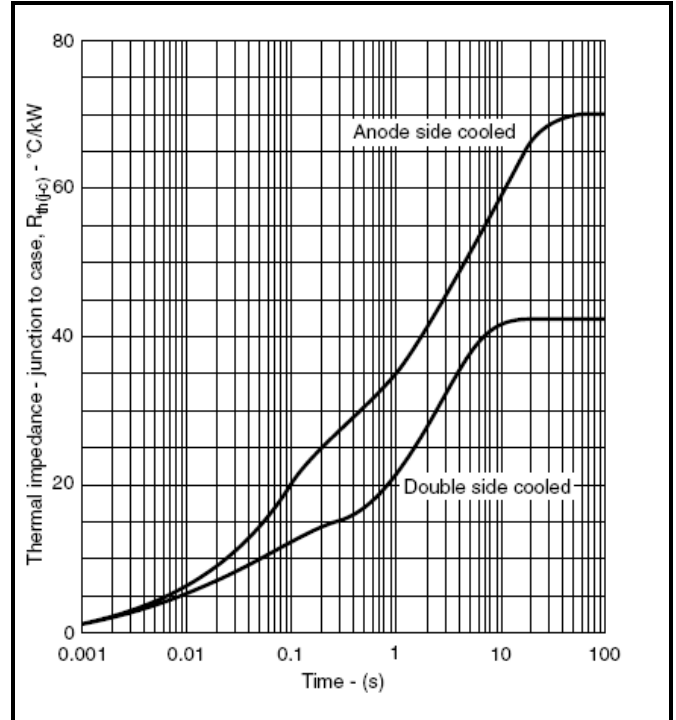


Fig.4 Transient thermal impedance- junction to case

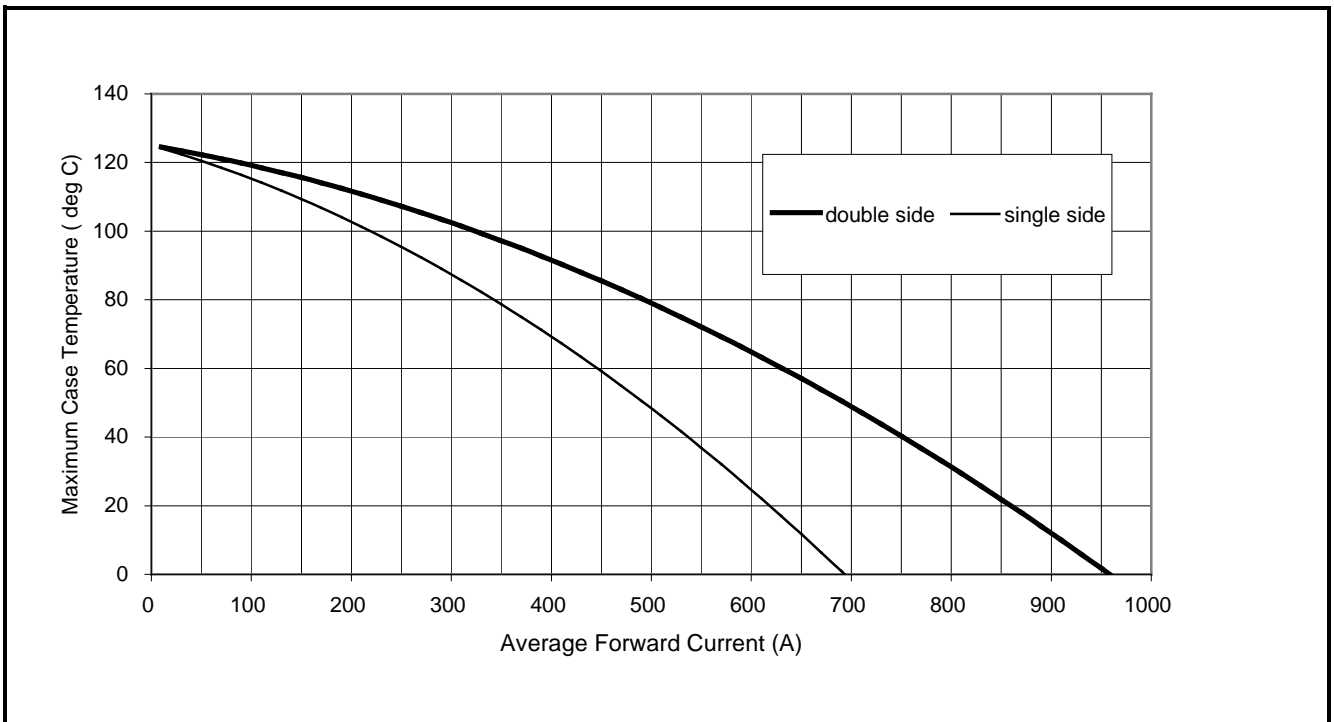


Fig.5 Average current rating vs temperature

PACKAGE DETAILS

For further package information, please contact Customer Services. All dimensions in mm, unless stated otherwise. DO NOT SCALE.

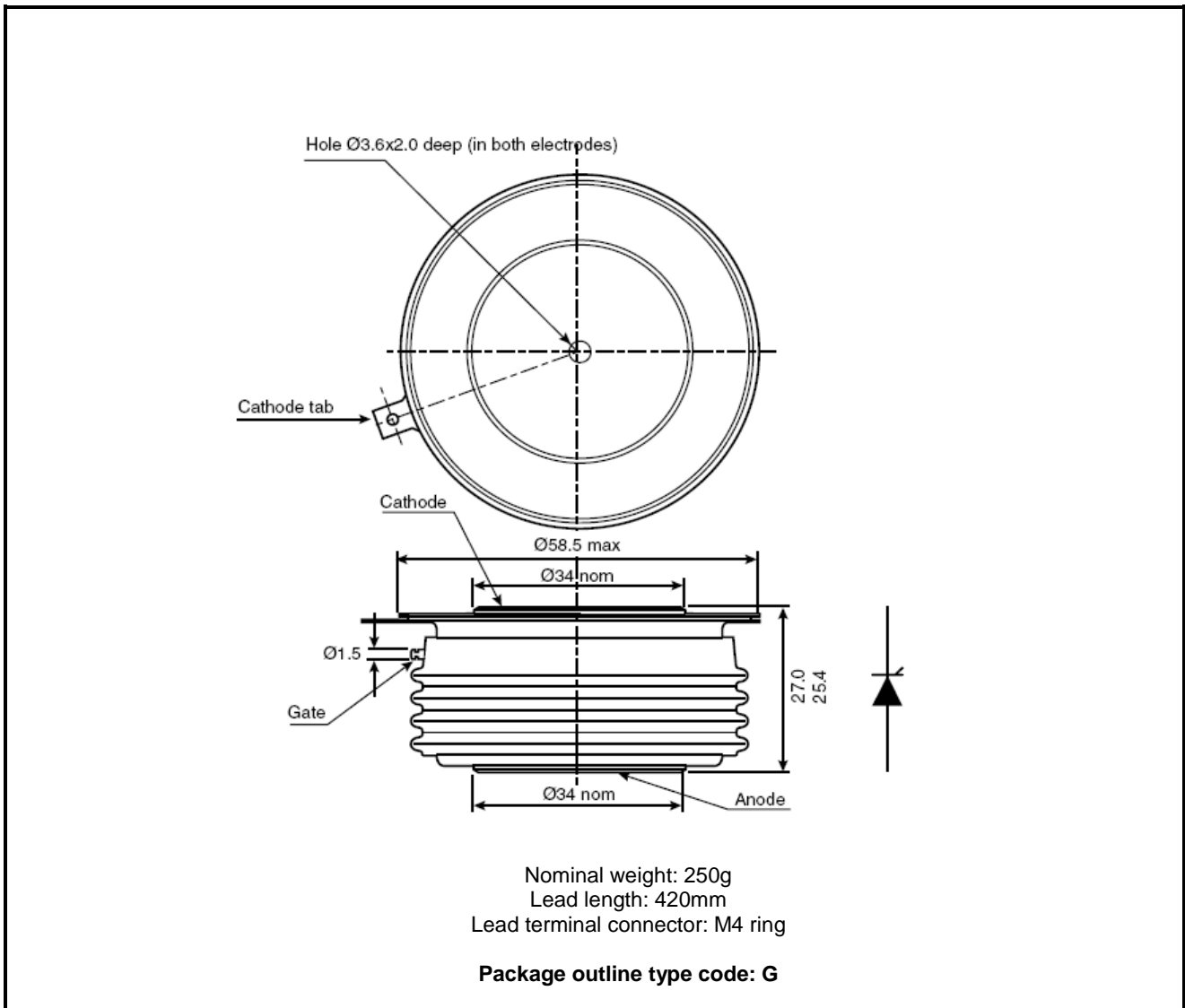


Fig.6 Package outline

POWER ASSEMBLY CAPABILITY

The Power Assembly group was set up to provide a support service for those customers requiring more than the basic semiconductor, and has developed a flexible range of heatsink and clamping systems in line with advances in device voltages and current capability of our semiconductors.

We offer an extensive range of air and liquid cooled assemblies covering the full range of circuit designs in general use today. The Assembly group offers high quality engineering support dedicated to designing new units to satisfy the growing needs of our customers.

Using the latest CAD methods our team of design and applications engineers aim to provide the Power Assembly Complete Solution (PACs).

HEATSINKS

The Power Assembly group has its own proprietary range of extruded aluminium heatsinks which have been designed to optimise the performance of Dynex semiconductors. Data with respect to air natural, forced air and liquid cooling (with flow rates) is available on request.

For further information on device clamps, heatsinks and assemblies, please contact your nearest sales representative or Customer Services.

Stresses above those listed in this data sheet may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed.



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